| | Application No. | Applicant(s) | |
|--|--|--|----------|
| Notice of Allowability | 10/734,296 | YAMASAKI ET AL. | M |
| | Examiner | Art Unit | |
| | Connie C. Yoha | 2827 | |
| The MAILING DATE of this communication app All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-88 NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT I of the Office or upon petition by the applicant. See 37 CFR 1.31 | S (OR REMAINS) CLOSED ir 5) or other appropriate communication is second communication. | n this application. If not included unication will be mailed in due cour | se. THIS |
| 1. This communication is responsive to <u>10/25/05</u> . | | | |
| 2. ☑ The allowed claim(s) is/are <u>1-32</u> . | | | |
| 3: Acknowledgment is made of a claim for foreign priority to a) All b) □ Some* c) □ None of the: 1. □ Certified copies of the priority documents have 2. □ Certified copies of the priority documents have 3. □ Copies of the certified copies of the priority documents have 3. □ Copies of the certified copies of the priority documents have 1. □ Copies of the certified copies of the priority documents have 1. □ A SUBSTITUTE OATH OR DECLARATION must be substituted. All □ A SUBSTITUTE OATH OR DECLARATION must be substituted. | ve been received. ve been received in Application ocuments have been received " of this communication to file MENT of this application. | on No If in this national stage application is a reply complying with the require | ements |
| INFORMAL PATENT APPLICATION (PTO-152) which gives. 5. CORRECTED DRAWINGS (as "replacement sheets") mu | ves reason(s) why the oath or | | 3E 01 |
| (a) ☐ including changes required by the Notice of Draftspe | | v (PTO-948) attached | |
| 1) hereto or 2) to Paper No./Mail Date | - | , | |
| (b) including changes required by the attached Examine Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR each sheet. Replacement sheet(s) should be labeled as such in | r's Amendment / Comment or | ne drawings in the front (not the bac | k) of |
| DEPOSIT OF and/or INFORMATION about the dep attached Examiner's comment regarding REQUIREMENT | osit of BIOLOGICAL MATI | ERIAL must be submitted. Note | the |
| | | | |
| Attachment(s) 1. ☐ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB. Paper No./Mail Date 4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material | 6. Interview So Paper No./ /08), 7. Examiner's | formal Patent Application (PTO-15 ummary (PTO-413), Mail Date Amendment/Comment Statement of Reasons for Allowan | |
| | COI PRIM | WNIE C. YOHA ARY EXAMINER | |

DETAILED ACTION

Response to Arguments

1. Examiner took notice of the remarks and amendments made by applicant filed on 10/25/05.

Response to Amendment

- 2. This office action is in response to Amendment filed on 10/25/05.
- 3. Claims 1-32 are pending.

Allowable Subject Matter

- 4. Claims 1-32 are allowed.
- 5. Claims 1-32 are considered allowable since prior art made of record and considered pertinent to the applicant's disclosure does not teach or suggest the claimed limitations having in combination with other features, a memory device having memory cell including an access transistor of an MISFET, wherein a positive power supply voltage is applied to the first bit line in a high level state and a ground voltage is applied to the first bitline in a low level state, wherein the access transistor is a depletion type p-channel MISFET, and wherein the ground voltage is applied to a gate electrode of the access transistor through the word line when the memory cell is in an activated state.

Prior art also does not disclose an integrated circuit having in combination with other features, a logic circuit which includes a p-channel MISFET and is integrated on a substrate; and a dynamic memory device provided on the substrate on which the logic circuit is provided, a memory cell including an access transistor of a p-channel MISFET,

Art Unit: 2827

wherein the threshold voltage of the access transistor is set to be higher than that of the p-channel MISFET provided in the logic circuit.

Page 3

Prior art also does not disclose an integrated circuit having in combination with other features, a logic circuit which includes a n-channel MISFET and is integrated on a substrate; and a dynamic memory device provided on the substrate on which the logic circuit is provided, a memory cell including an access transistor of a n-channel MISFET, wherein the threshold voltage of the access transistor is set to be lower than that of the n-channel MISFET provided in the logic circuit.

Conclusion

- 6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to whose telephone number is (571) 272-1799. The examiner can normally be reached on Mon. Fri. from 8:00 A.M. to 5:30 PM. The examiner's supervisor, Amir Zarabian, can be reached at (571) 272-1852. The fax phone number for this Group is (703) 872-9306. Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the Group receptionist whose telephone number is (703) 305-0956.
- 7. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov should you

Art Unit: 2827

have questions on access to the Private Pair system, contact the Electronic Business

Center (EBC) at 866-217-9197 (toll-free).

C.Yoha

December 2005

CONNIE C. YOHA